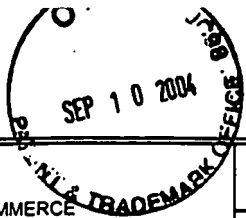


FORM PTO 1449 (modified)		ATTY DOCKET NO. 03500.018000		APPLICATION NO. 10/808,481	
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		APPLICANT Naoya Kawamura, et al.			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)		FILING DATE March 25, 2004		GROUP 1745	
Date Submitted: September 10, 2004					
U.S. PATENT DOCUMENTS					
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUBCLASS FILING DATE IF APPROPRIATE
/LW/		5,800,939	09/01/1998	Mishina et al.	429 57
		5,998,063	12/07/1999	Kobayashi et al.	429 218.1
		6,558,848 B1	05/06/2003	Kobayashi et al.	429 241
		6,517,974 B1	02/11/2003	Kobayashi et al.	429 231.95
		6,569,568 B2	05/27/2003	Kobayashi et al.	429 221
		6,372,387 B1	04/16/2002	Kawakami et al.	429 303
		6,377,030 B1	04/23/2002	Asao et al.	320 161
		6,558,847 B1	05/06/2003	Kawakami et al.	429 231.95
		5,824,434	10/20/1998	Kawakami et al.	429 209
		5,491,037	02/13/1996	Kawakami	429 49
		5,882,811	03/16/1999	Kawakami	429 49
/LW/		5,702,845	12/30/1997	Kawakami et al.	429 224
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS SUBCLASS TRANSLATION YES/NO/ OR ABSTRACT
/LW/		11-283627	10/15/1999	JAPAN	Abstract
/LW/		2000-311681	11/07/2000	JAPAN	Abstract
/LW/		WO 00/17949	03/30/2000	PCT	Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)					
EXAMINER			DATE CONSIDERED		
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/LW/		5,728,482	03/17/1998	Kawakami et al.	429	10	
		5,888,666	03/30/1999	Kawakami	429	62	
		6,051,340	04/18/2000	Kawakami et al.	429	231.95	
		6,596,432 B2	07/22/2003	Kawakami et al.	429	60	
		5,641,591	06/24/1997	Kawakami et al.	429	218	
		5,698,339	12/16/1997	Kawakami et al.	429	212	
		6,063,142	05/16/2000	Kawakami et al.	29	623.5	
		6,165,642	12/26/2000	Kawakami et al.	429	218.1	
		6,638,322 B1	10/28/2003	Kawakami et al.	29	623.1	
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		5,919,589	07/06/1999	Kawakami et al.	429	231.8	
/LW/		6,329,096 B2	12/11/2001	Kawakami et al.	429	49	
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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
/LW/		2000-215887	08/04/2000	JAPAN			Abstract
/LW/		2002-352797	12/06/2002	JAPAN			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
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PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
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	6,730,434 B1	05/04/2004	Kawakami et al.	429	218.1	
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	6,383,686 B1	05/07/2002	Umeno et al.	429	231.8	
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/LW/	2002/0055041 A1	05/09/2002	Kobayashi et al.	429	221	

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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